## Application/Control No. Applicant(s)/Patent Under Reexamination 10/786,472 ICHIHARA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3681 Rodney H. Bonck **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0085091 A1	05-2003	Ichihara et al.	192/45
*	В	US-2003/0000792 A1	01-2003	Fujiwara, Hideki	192/45
	C	US-			
	D	US-			
	Е	US-			
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	G	US-			
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	Ι	US-			
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	К	US-			
	L	US-			
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## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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